

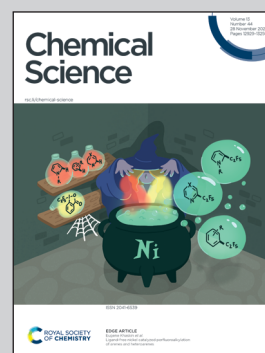


Showcasing research from Professor Wu and Cheng's laboratory, Department of Chemistry, National Tsing Hua University, Hsinchu, Taiwan.

Substituent engineering of the diboron molecular architecture for a nondoped and ultrathin emitting layer

Nondoped OLEDs require emitters that resist aggregation-caused quenching. However, such neat materials with high photoluminescence quantum yield are still rare. We demonstrate the guideline of substituent modification of a CzDBA. The suggested position of a bulky group decreases the aggregation level and increases the molecular aspect ratio. *t*BuCzDBA exhibits the excellent optical properties and horizontal emitting dipole ratio for fabricating a high-performance nondoped OLED. Remarkably, a state-of-the-art OLED with the 1-nm-thick emitting layer and high efficiency was developed, and it offers the benefits of simplified fabrication and power-saving.

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Substituent engineering of the diboron molecular architecture for a nondoped and ultrathin emitting layer†

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Owing to the high technology maturity of thermally activated delayed fluorescence (TADF) emitter design with a specific molecular shape, extremely high-performance organic light-emitting diodes (OLEDs) have recently been achieved *via* various doping techniques. Recently, undoped OLEDs have drawn immense attention because of their manufacturing cost reduction and procedure simplification. However, capable materials as host emitters are rare and precious because general fluorophores in high-concentration states suffer from serious aggregation-caused quenching (ACQ) and undergo exciton quenching. In this work, a series of diboron materials, CzDBA, iCzDBA, and tBuCzDBA, is introduced to realize the effect of steric hindrance and the molecular aspect ratio *via* experimental and theoretical studies. We computed transition electric dipole moment (TEDM) and molecular dynamics (MD) simulations as a proof-of-concept model to investigate the molecular stacking in neat films. It is worth noting that the pure tBuCzDBA film with a high horizontal ratio of 92% is employed to achieve a nondoped OLED with an excellent external quantum efficiency of 26.9%. In addition, we demonstrated the first ultrathin emitting layer (1 nm) TADF device, which exhibited outstanding power efficiency. This molecular design and high-performance devices show the potential of power-saving and economical fabrication for advanced OLEDs.

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Introduction

Organic light-emitting diodes (OLEDs) have achieved very high efficiency by employing thermally activated delayed fluorescence (TADF)¹ and molecular self-alignment² so far. Pure-organic emitters with TADF properties possess reverse intersystem crossing (RISC)³ to achieve electroluminescent (EL) devices with nearly 100% internal quantum efficiency (IQE).^{4,5} Moreover, the enhancement of the device out-coupling efficiency was realized by employing dopant emitters with highly horizontal emitting dipole orientation.^{2,6} Generally, the molecular shape and transition dipole moment can cause a certain molecular orientation and alignment in thin film, and the rod-

like, disk-like molecules^{2,7,8} show a trend of preferential horizontal ratio (up to ~97%). With the cooling substrate method,⁹ the completely horizontal orientation (100%) could be even achieved. Recently, the doping technique has played a vital role in high-performance OLEDs and commercial panels because most luminophores suffer from serious emission quenching in high-concentration doped and neat films. To avoid a harmful nonradiative process occurring, the guest/host system in the emitting layer (EML) has dominated most OLED configurations nowadays. However, the co-doping method in the fabrication process requires accurate deposition rate control and excessive use of chemicals, which might generate extra chemical waste and make recycling difficult. Furthermore, doped-type TADF OLEDs often show a high efficiency roll-off at a high luminance because exciton annihilation arises when TADF emitters with a long excited-state lifetime cause singlet-triplet and triplet-triplet annihilation (STA and TTA),¹⁰ which means a high concentration of excitons is formed in the EML and will increase the probability of annihilation and energy loss.¹¹

Previous studies pointed out that an increasing doping ratio (especially for nondoped) of the EML can reduce the efficiency roll-off issue.^{12,13} However, emitters with an aggregation-quenching nature in high-concentration doping status still cause a considerable issue. To deal with the dilemma of the high-performance and nondoped OLEDs, the design and investigation of the host emitter

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is the primary task. Fluorescence aggregation-caused quenching (ACQ) generally occurs due to the high tendency towards π - π stacking of fluorophores. Specifically for emitters in the solid state, the ACQ effect is obviously harmful to optical applications, resulting in low emission intensity and considerable efficiency loss. The strategy of twisted structure or bulky substituent is a technique for reducing the degree of intermolecular aggregation in thin films. An emitter with a sterically hindered group¹⁴ or conformational heterogeneity¹⁵ might increase the distance between nearby molecules in the packing status. However, there is no systematic guide for designing efficient nondoped emitters with precise substituent positions. In another aspect, the development of nondoped OLEDs offers an avenue for the exploration of an extremely simplified device, which makes the EML ultrathin and greatly reduces its power consumption.¹⁶ The OLEDs with around 1 nm of EML thickness, low driving voltage (<3.0 V), and high efficiency have been demonstrated by Ma *et al.*, who reported various color OLEDs and WOLEDs by using phosphorescent dyes.^{17–19} With the nondoped and ultrathin EML, the OLEDs can have the merits of energy-saving and cost-effective fabrication simultaneously.

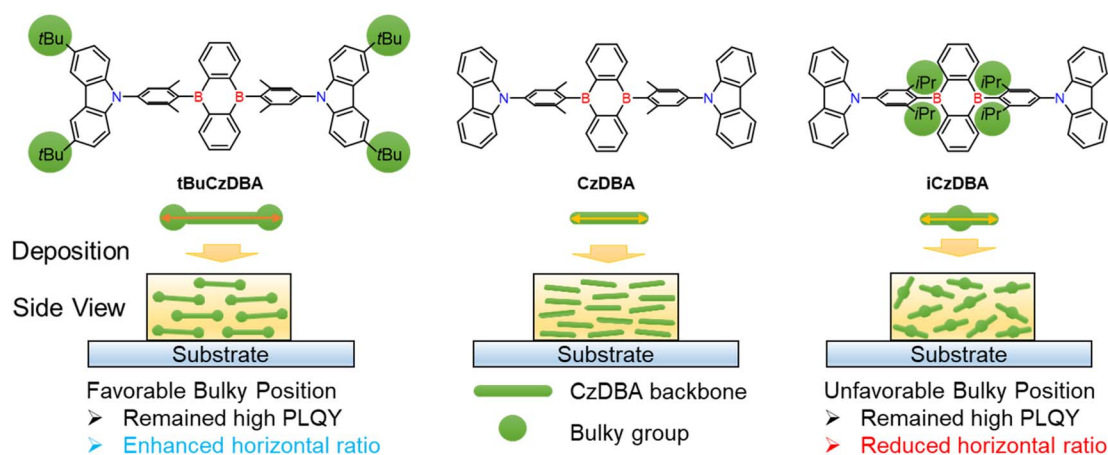
In our previous study, two diboron-based TADF materials, CzDBA and *t*BuCzDBA, can be applied to high-performance OLEDs due to their high PLQYs, short delayed lifetimes, and rod-like molecular shape.²⁰ In particular, we noticed that these emitters have less self-quenching ability in neat films, which could also account for a low efficiency roll-off device. Notably, for *t*BuCzDBA with the *tert*-butyl group at the 3,6-position of the carbazole donor, a slight reduction of PLQY (86 to 84%) and a reduced red-shifted PL band (8 nm) in the neat film were observed compared to its doped film condition (10 wt% in CBP). Therefore, diboron compounds with a twisted molecular structure and bulky substituents are capable of lowering the degree of aggregation. As per our expectation, CzDBA has been employed for a single-layer emitter device by Kotadiya *et al.*,²¹ and their nondoped device shows good efficiency of 19% external quantum efficiency (EQE) and a relatively long operation lifetime up to 1880 hours. Furthermore, the out-coupling efficiency is estimated to be 26% by varying the CzDBA thickness.²²

Herein, we propose a design rule to demonstrate the importance of bulky substituent positions toward molecular design in the pristine solid state. The proposed strategy of engineering the diboron molecular shape with a highly horizontal emitting dipole orientation is shown in Scheme 1. We assume that the higher molecular aspect and suitable bulky group position can promote the horizontal ratio in a neat film. To prove the concept, two modified CzDBA derivatives with bulky substituents on the middle or terminal side are introduced to investigate the packing distance, emission quenching properties, and horizontal ratio. Our theoretical calculations and molecular dynamics simulations all support our hypothesis. As a result, *t*BuCzDBA with the bulky substituent and highest aspect ratio²³ not only decreases the ACQ effect but also exhibits the highest horizontal ratio (92%) under neat film conditions. In contrast, *i*CzDBA displays the lowest horizontal ratio (77%), which is even lower than that of basic CzDBA (88%). Remarkably, the nondoped device with *t*BuCzDBA without any doping technique exhibits an excellent EQE of 26.9% among pure-organic nondoped OLEDs.^{24–27} To further reduce the EML thickness, the ultrathin TADF OLED is demonstrated by employing only 1 nm of *t*BuCzDBA. It is worth noting that ultrathin EML devices show a high power efficiency of 95.3 lm W⁻¹ and the lowest driving voltage of 2.1 V, which are rather comparable to recent state-of-the-art nondoped OLEDs.

Results and discussion

Synthesis and characterization

We had reported and synthesized a series of 9,10-dihydro-9,10-diboraanthracene (DBA) compounds²⁰ *via* the nucleophilic arylation of lithiated carbazole derivatives with 9,10-dibromo-9,10-diboraanthracene (DBDBA).²⁸ In comparison with *t*BuCzDBA, the bulky isopropyl group was introduced into the middle phenyl group of CzDBA for the synthesis of *i*CzDBA. Three DBA-based structures are shown in Scheme 1 and the synthetic details of *i*CzDBA are shown in the ESI (Scheme S1 and Fig. S1–S4†). Thermal gravimetric analysis (TGA) and differential scanning calorimetry (DSC) measurements under a nitrogen atmosphere were performed. *i*CzDBA has lower thermal



Scheme 1 The molecular structures of the diboron-based materials and the substituent engineering strategy of the emitters in neat films.



stability compared to CzDBA and *t*BuCzDBA. The decomposition temperature (T_d) is around 338 °C and the glass transition temperature (T_g) was not detected (Fig. S5†). The HOMO and LUMO levels of *i*CzDBA are -5.91 and -3.31 eV, respectively, determined from photoelectron spectroscopy (Fig. S6†) and optical band gap (E_g). The HOMO and LUMO distributions in *i*CzDBA were well separated between Cz and DBA motifs by using density functional theory (DFT) calculation at the BMK/6-31G* level, as shown in Fig. S7.† The details of material characterization are shown in the Experimental section.

All single crystals of DBA derivatives were grown and prepared by the sublimation method under low pressure (10^{-6} torr). The cell parameters are summarized in Table S1,† while crystal packing and stacking distance are shown in Fig. S8.† Although the single-crystal structures of CzDBA and *t*BuCzDBA have been revealed in a previous study,²⁰ the crystal stacking details and comparison are further discussed here. *i*CzDBA has a D-A-D framework and rod-like design, and all organoboron derivatives adopt a highly twisted structure with two dihedral angles between the disubstituted phenylene bridge and the neighboring Cz/DBA group, as shown in Fig. S9.† Except for *i*CzDBA, the larger dihedral angles that appear between the bridge group and the DBA acceptor are around 78°. The isopropyl groups of *i*CzDBA make the single-crystal structure slightly torsional and asymmetric. Additionally, CzDBA, *i*CzDBA, and *t*BuCzDBA packed in the $C2/c$, $P2_1/c$, and $P\bar{1}$ packing motif, respectively. The crystal packing of the three compounds was step-like stacking. *t*BuCzDBA with the largest

bulky group exhibits a different crystalline system (triclinic) from others (monoclinic), showing a herringbone-type arrangement along the a axis in the crystal cell. The closest intermolecular distance of the DBA plane between two adjacent molecules is 6.12, 7.28 and 7.46 Å, respectively, for CzDBA, *i*CzDBA, and *t*BuCzDBA. The results showed that the values are higher than 6.0 Å, which might indicate that there is barely π - π interaction between nearby molecules in crystal packing. Therefore, *i*CzDBA and *t*BuCzDBA with additional bulky groups truly enlarge the distance and become more loose packing, which reveals that the further reduction of the ACQ process might exist in their neat films.²⁹ To realize whether the dimers exist or not in pristine solid films, we performed TDDFT simulations of the three emitters. Their singlet excitations are mainly intramolecular CT transitions, as evidenced by the FMOs (Fig. S7†) and “holes” and “electrons” equally distributed on two molecules (Fig. 1), implying that dimer formation does not occur to a significant extent in these three molecules. Therefore, undesirable interactions may be suppressed due to crystal packing and stacking distance in their neat films.

Theoretical prediction of molecular orientation

In order to investigate the molecular orientation in neat films, we looked into the optimized structure for each molecule and computed the TEDM with the optimized S_1 state of crystal structures (Fig. 2a). In the crystal-packing diagram, the three molecules tend to be aligned nearly parallel to their acceptor planes; thus, the TEDMs of CzDBA, *i*CzDBA, and *t*BuCzDBA

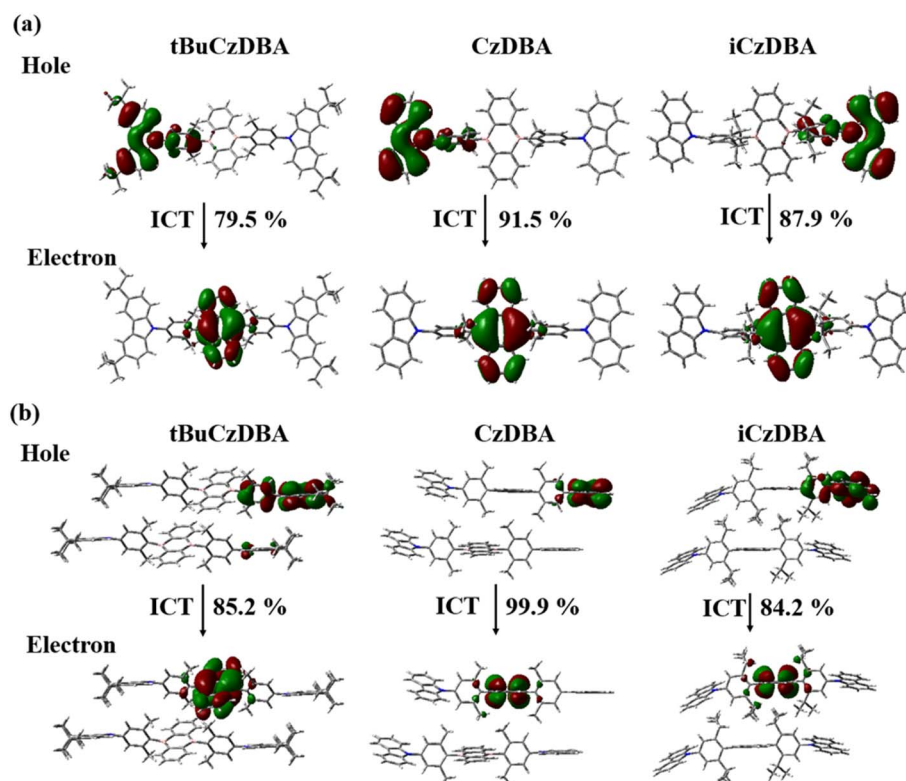


Fig. 1 The natural transition orbitals (NTO) of CzDBA, *i*CzDBA, and *t*BuCzDBA of (a) single-crystal structures and (b) dimer crystal structures are calculated at the BMK/6-31G* level.



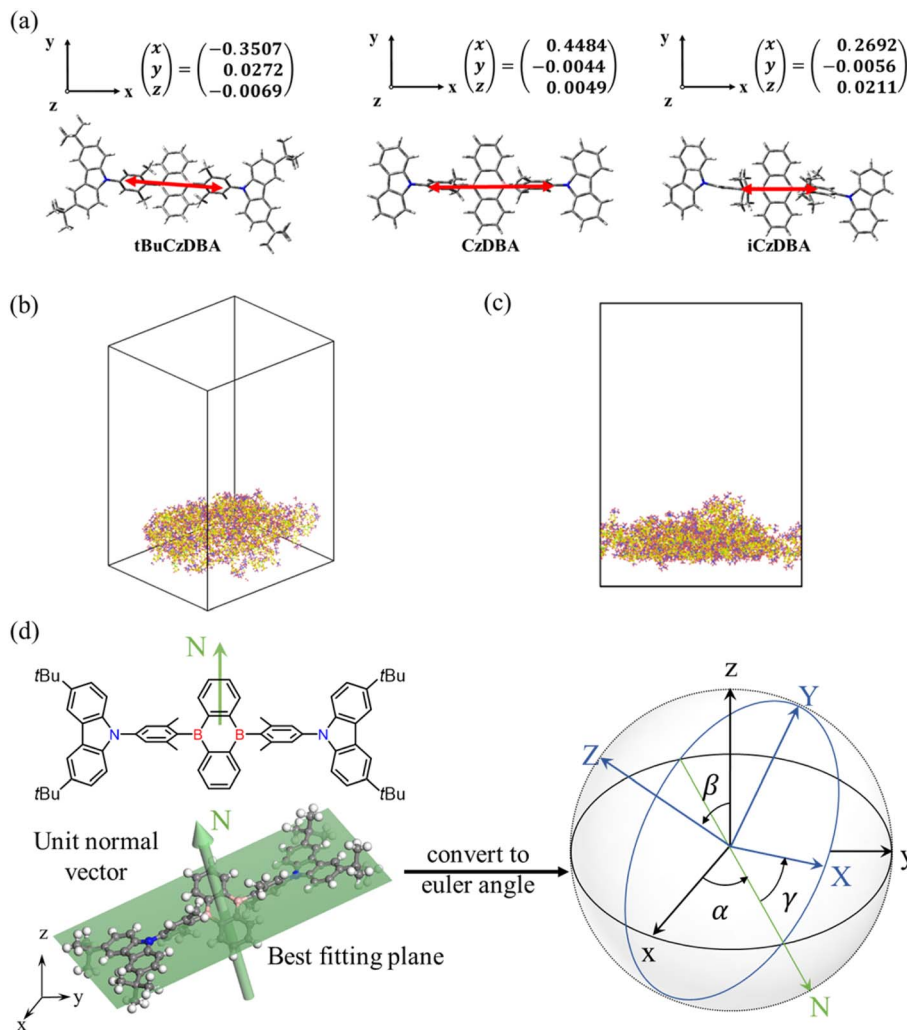


Fig. 2 (a) The transition dipole moment vectors and the direction of calculated transition dipole moments for CzDBA, iCzDBA, and tBuCzDBA relative to the coordinate of the molecular structure. (b) Molecular representation of the deposition layer. (c) Deposition layer structure after cooling and equilibrium. (d) The representation of the molecular plane and the direction of unit normal; the stereographic projections are applied to examine the preferred orientation of each amorphous layer.

were simulated with their corresponding acceptor moieties as the x - y plane. Eventually, in DBA derivatives, the direction of TEDM is more elongated along the long molecular axis, which could be attributed to the larger contribution of the acceptor unit with an expanded plane to the terminal carbazole part. All TEDM vectors of the three molecules mainly aligned on the plane of their corresponding acceptor moieties, and the TEDM vectors of the CzDBA and tBuCzDBA had lower z components, which reveals the high horizontal emitting dipole orientation features.

As shown in Fig. 2b–c and Fig. S10,[†] a significant difference was found among CzDBA, iCzDBA, and tBuCzDBA using nonequilibrium molecular dynamics (NEMD). The methods and parameters for simulations are summarized in Table S3[†] and the Experimental section. Moreover, we used stereographic projections to represent the orientation distribution of each molecule, as shown in Fig. 2d. The x , y , and z axes are shown as (001), (010), and (001), respectively. Fig. S11[†] reveals a horizontal

alignment for each system. As a result, the orientation of the tBuCzDBA amorphous layer indicates the normal discretion of each molecule toward the (001) direction. On the contrary, CzDBA and iCzDBA show less significant difference or preferred orientations. Accordingly, tBuCzDBA possesses a preferentially horizontal orientation in both TEDM calculation and MD simulation, which could establish a basis for constructing nondoped OLEDs with high light out-coupling efficiency.

Photophysical properties

The comparison of CzDBA and tBuCzDBA between the doped film and neat film has been previously reported,²⁰ and reduced self-quenching characteristics have been observed. The photophysical properties of newly synthesized iCzDBA are similar to those of CzDBA in solution and the doped CBP film, as shown in Fig. S12.[†] iCzDBA shows a maximum absorption peak at 344 nm, assigned to a π to π^* transition. The intramolecular charge transfer (ICT) absorption is likely assigned as the broad



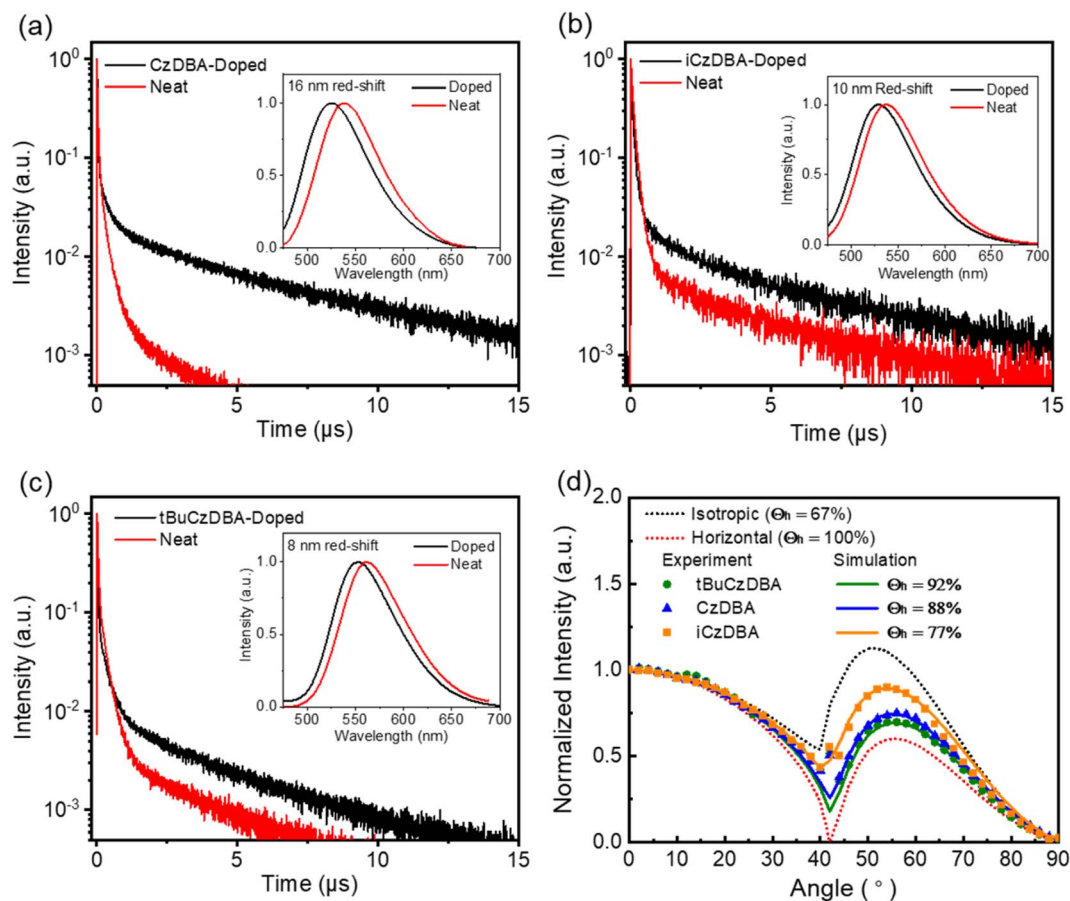


Fig. 3 (a) Transient PL decay curves and fluorescence spectra in the inset of doped and neat films for (a) CzDBA, (b) iCzDBA, and (c) tBuCzDBA. (d) Variable-angle PL measurements of all 30 nm-thick neat films.

shoulder band that appears around 420 nm. Fig. S12[†] shows the obvious solvent effect in the PL spectra of iCzDBA, and the emission maximum observed at 526 nm in toluene shifted to 586 nm in dichloromethane, which further supports the ICT characteristics. The similar ΔE_{ST} value of 33 meV, which is very close to that of CzDBA, was determined *via* the fluorescence and phosphorescence spectra of the 10 wt% iCzDBA doped CBP film. Nevertheless, the photophysical properties of iCzDBA in the neat film are different from those of CzDBA. Fig. 3 exhibited the emission peaks for CzDBA, iCzDBA, and tBuCzDBA in neat film, which are 540, 538, and 561 nm, respectively. And, they have the peaks red-shifted by 16, 10, and 8 nm, compared with their corresponding 10 wt% doped CBP films. The photophysical data of doped and neat films are recorded in Table S4.[†] The emission decay curves of the doped film and neat film are shown in Fig. 4a–c. For the pristine films, the lifetimes of delayed components (τ_d) were reduced to 1.0, 1.4, and 1.2 μs for CzDBA, iCzDBA, and tBuCzDBA, respectively, compared with each doping condition (10 wt% in CBP). Significantly, their PLQYs in neat films still remain at high values of 90.6%, 88.0%, and 84.0% for CzDBA, iCzDBA, and tBuCzDBA, respectively. The rate constants of RISC (k_{RISC}) in neat films were calculated to be $2.36 \times 10^6 \text{ s}^{-1}$, $1.92 \times 10^6 \text{ s}^{-1}$, and $2.02 \times 10^6 \text{ s}^{-1}$, respectively, for CzDBA, iCzDBA, and tBuCzDBA. The employed method³⁰

and all parameters are summarized in Table S5.[†] By comparing the results between the neat film and doped film, we believe the shorter τ_d in neat films accounts for the factor, generating relatively higher k_{RISC} , and the trend was consistent with the reported results from the nondoped emitter film.^{11,12,31} However, the relatively serious ACQ effect still existed in CzDBA, due to the highest 16 nm emission red-shift and a 9.4% decline of PLQYs between the doped and neat films. In a similar manner, the time-resolved PL of CzDBA also exhibited a relatively dramatic difference between doped and neat films, compared to the spectra from iCzDBA and tBuCzDBA. In addition, the emission quenching level between doped and neat films probably correlates with the trends of the closest distance in single-crystal packing. Notably, tBuCzDBA displays the longest distance of 7.46 \AA ; thus, the most reduced self-quenching phenomenon was measured among the three DBA compounds. In short, the steric hindrance of the *tert*-butyl or isopropyl group has been evidenced to disperse the molecular aggregation²⁹ and further reduce the ACQ process in neat films.

According to the reported literature,⁷ the molecular design containing rod-like and linear-type structures is suggested for increasing the horizontal emitting dipole orientation (Θ_h) in thin films. Specifically for the high aspect ratio design,^{32,33} a molecule with the long axis tends to parallelly lie to the



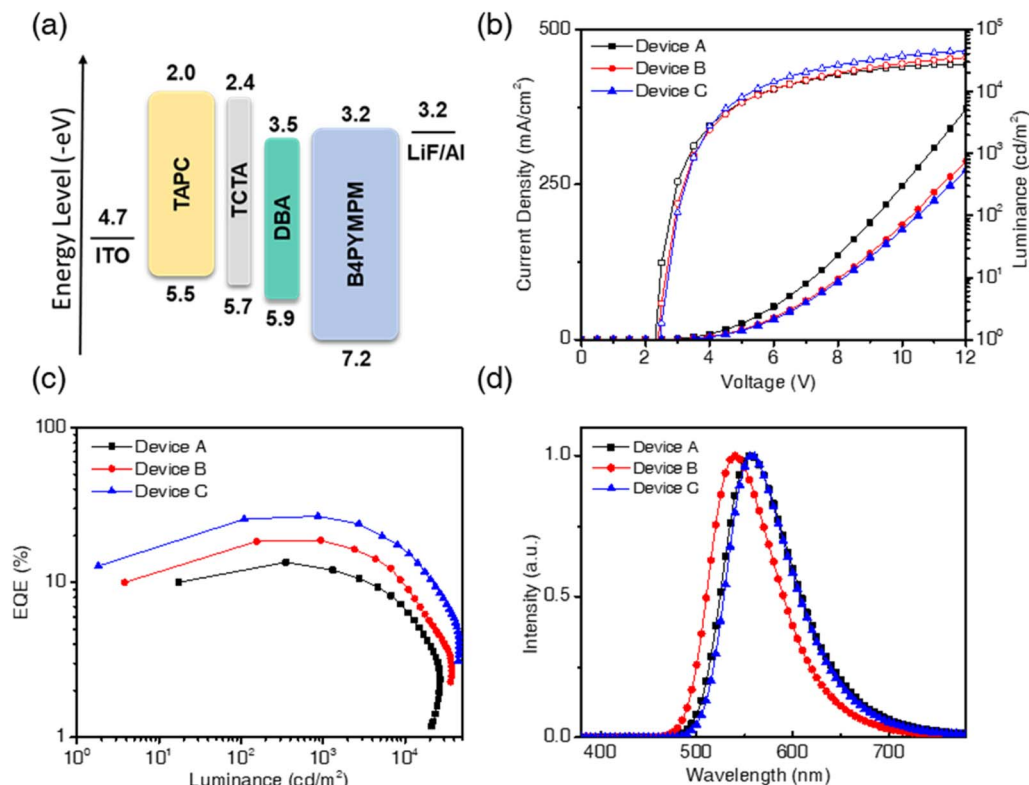


Fig. 4 (a) Nondoped device configurations and energy levels. (b) Current density and luminance versus voltage characteristics. (c) External quantum efficiency versus luminance characteristics. (d) Electroluminescence spectra at 8 V.

substrate plane under vacuum evaporated deposition. The horizontal ratios of DBA derivatives in CBP were measured and analyzed by using variable-angle PL measurement, showing a relatively high Θ_h around 83–84%.²⁰ Fig. S13† shows that the Θ_h of iCzDBA was determined to be 84% in the 10 wt% doped CBP film, due to the similar structure of CzDBA. To our surprise, the experimental results determined from their neat films are significantly different from those of their doped films. The Θ_h of CzDBA, iCzDBA, and *t*BuCzDBA in their neat films was determined to be 88%, 77%, and 92%, respectively, as shown in Fig. 3d. The trend of Θ_h is consistent with the spectroscopic ellipsometry characterization of 100 nm-thick neat films (Fig. S14†). Fluorescence and phosphorescence dyes with a horizontal ratio higher than 90%^{32–35} are rare. More importantly, the difference of emitting dipole orientation between neat and doped films was observed, indicating the significance

of molecular shape for enhanced horizontal ratio in neat films. In order to engineer the molecular structure for low emission quenching and high Θ_h , *t*BuCzDBA with the highest aspect ratio manifest both advantages. Compared to iCzDBA, *t*BuCzDBA with bulky groups added on the terminal side of CzDBA truly extends the long axis, modifying the anisotropic orientation and further increasing the Θ_h to 92% in the neat film. The results are in good agreement with the TEDM calculations and MD simulations.

Nondoped and ultrathin EML devices

To study the performance of nondoped OLEDs, we fabricated the EL devices A, B, and C by using CzDBA, iCzDBA, and *t*BuCzDBA, respectively, as the host emitters. These nondoped devices without any doping technique were fabricated *via* the

Table 1 Summary of nondoped OLED performance using DBAs as the host emitter

Device ^a	EML ^a	V_d [V] ^b	$\eta_{EQE,max}$ [%] ^c	$\eta_{EQE,1000}$ [%] ^d	$\eta_{CE,max}$ [cd A ⁻¹] ^e	$\eta_{PE,max}$ [lm W ⁻¹] ^f	η_{EL} [nm] ^g	L [cd m ⁻²] ^h	CIE [x, y] ⁱ
A	CzDBA	2.3	13.5	12.5	42.1	44.1	557	26 737	(0.44, 0.55)
B	iCzDBA	2.4	18.7	18.6	65.5	66.9	540	37 325	(0.38, 0.59)
C	<i>t</i> BuCzDBA	2.4	26.9	26.6	86.9	86.3	558	45 727	(0.44, 0.55)

^a Device configuration: ITO/TAPC (50 nm)/TCTA (10 nm)/EML (15 nm)/B4PYMPM (65 nm)/LiF (1 nm)/Al (100 nm). ^b The operating voltage at a brightness of 1 cd m⁻². ^c EQE, maximum external quantum efficiency. ^d The EQE was measured at 1000 cd m⁻². ^e CE, maximum current efficiency. ^f PE, maximum power efficiency. ^g The EL emission peak at 8 V. ^h The maximum luminance. ⁱ CIE 1931 coordinates.



four-organic-layer configuration: ITO/TAPC (50 nm)/TCTA (10 nm)/diboron compounds (15 nm)/B4PYMPM (65 nm)/LiF (1 nm)/Al (100 nm), where di-[4-(*N,N*-di-*p*-tolyl-amino)-phenyl]cyclohexane (TAPC) is the hole transporting material, tris(4-(9*H*-carbazol-9-yl)phenyl)amine (TCTA) serves as the electron/exciton blocker, and 4,6-bis(3,5-di(pyridin-4-yl)phenyl)-2-methylpyrimidine (B4PYMPM) acts as the electron transporter. The energy levels of related materials and EL characteristics are shown in Fig. 4 and summarized in Table 1.

All devices show relatively low driving voltages (2.3–2.4 V) among present OLED devices. The λ_{EL} of devices A, B, and C was 557, 540, and 558 nm, and the corresponding Commission Internationale de L'Eclairage (CIE) coordinates are located in the yellow region of (0.44, 0.55), (0.38, 0.59), and (0.44, 0.55), respectively. The measured EQEs of devices A, B, and C were 13.5%, 18.7%, and 26.9%; the current efficiencies (CEs) were 42.1, 65.5, and 86.9 cd A^{-1} , and the power efficiencies (PEs) were 44.1, 66.9, and 86.3 lm W^{-1} , respectively, as shown in Fig. S15.† However, CzDBA shows the highest PLQY in neat film, whereas the lowest EQE was undesirably found in the nondoped device. The inconsistent quantum efficiency was observed under PL and EL conditions, and the resemble issues had been revealed in other materials and nondoped devices. For example, some TADF emitters with high PLQYs (81.5–97%) in neat films gave low EQEs (9.2–14.2%) in reported nondoped devices.^{11,12,36,37}

However, assuming each device's out-coupling efficiency is around 20%, their ideal device EQEs should be around 16–20%. Thus, those devices with such low EQEs revealed considerable exciton quenching in nondoped devices. To solve the problem of emitters giving high PLQY and low-performance devices, the introduction of the bulky group and steric hindrance into the molecular structure offers a breakthrough. Such high performance in the recent developments of nondoped devices was achieved by employing emitters with high steric hindrance.^{11,38} Thus, device C with *t*BuCzDBA showed the best efficiencies, which is consistent with the existence of the high PLQY and Θ_{h} characteristics in neat films as per our expectation. Device B also showed good performance, but the inappropriate position of the bulky isopropyl groups in *i*CzDBA results in the lowest horizontal ratio and decreases the device efficiency compared to device C. Except for device A, the nondoped devices B and C both exhibited low efficiency roll-off values of 0.5 and 1.1% at 1000 cd m^{-2} . The superior performance of the reduced efficiency roll-off properties generally exists in nondoped^{25,39,40} or AIE-based^{12,13,31,41} OLEDs. We believe that the high RISC rate of diboron compounds and the low degree of self-quenching in neat films mainly account for such high performance.

Generally, the thickness of the EML in most nondoped OLEDs is around 30–40 nm. In view of our simple device containing a relatively thin EML (15 nm), the exploitation of an

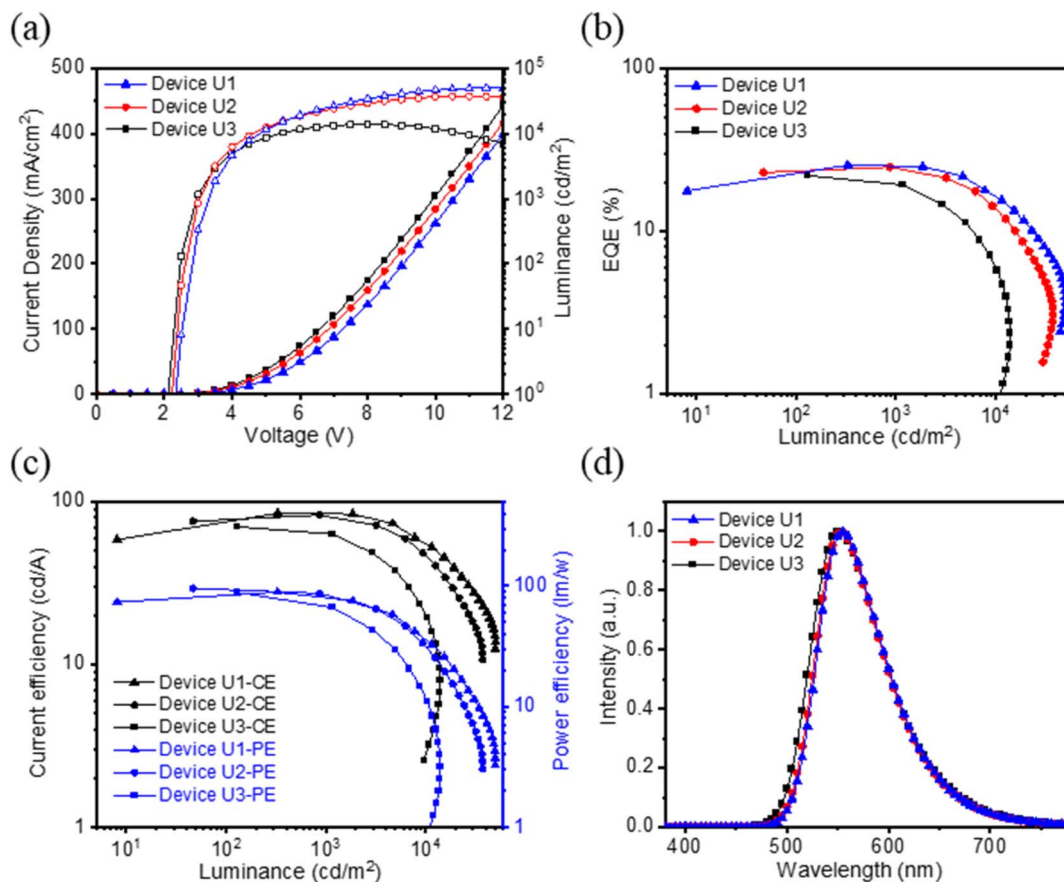


Fig. 5 Ultrathin EML devices U1, U2, and U3: (a) Current density and luminance versus voltage plot. (b) EQE versus luminance plot. (c) CE and power efficiency PE versus luminance. (d) Electroluminescence spectra at 8 V.



Table 2 Performance of thinner EML devices with *t*BuCzDBA

Device ^a	EML Thickness [nm] ^a	V_d [V] ^b	$\eta_{\text{EQE,max}}$ [%] ^c	$\eta_{\text{CE,max}}$ [cd A ⁻¹] ^d	$\eta_{\text{PE,max}}$ [lm W ⁻¹] ^e	η_{EL} [nm] ^f	CIE [x, y] ^g
U1	10	2.3	25.5	85.0	89.0	555	(0.44, 0.55)
U2	5	2.2	24.5	82.9	95.3	553	(0.38, 0.59)
U3	1	2.1	22.0	70.2	88.2	552	(0.44, 0.55)

^a Device configuration: ITO/TAPC (50 nm)/TCTA (10 nm)/*t*BuCzDBA (1–10 nm)/B4PYMPM (65 nm)/LiF (1 nm)/Al (100 nm). ^b The operating voltage at a brightness of 1 cd m⁻². ^c EQE, maximum external quantum efficiency. ^d CE, maximum current efficiency. ^e PE, maximum power efficiency. ^f The EL emission peak at 8 V. ^g CIE 1931 coordinates.

ultrathin EML device is considered. We employed *t*BuCzDBA for fabricating three thinner EML devices U1, U2, and U3; the corresponding EML thicknesses were narrowed down to 10, 5, and 1 nm, respectively. Notably, the EQEs of devices U1, U2, and U3 remained at a high level, giving 25.5%, 24.8%, and 22.0%, respectively. And the corresponding CEs were 85.0, 82.9, and 70.2 cd A⁻¹, and PEs were 89.0, 95.3, and 88.2 lm W⁻¹, respectively, as shown in Fig. 5. Compared to device C, the efficiencies of devices U1–U3 are all reduced, while the driving voltages of the devices declined from 2.4 to 2.1 V, along with the reducing EML thickness from 15 nm to 1 nm. All characteristics of devices U1–U3 are summarized in Table 2. The unprecedented PE of 95.3 lm W⁻¹ (ref. 26) was achieved by device U2 due to the low driving voltage of only 2.2 V. To elaborate on the superior performance of the thin EML, we made the 1 nm and 15 nm hole-only and electron-only devices based on *t*BuCzDBA. We then calculated the charge mobility using the space charge limited current (SCLC) method (Fig. S16 and Table S6†). We found that the charge mobilities grew closer in 1 nm devices, implying more balanced carrier injections. To verify the stability of the 1 nm-thick EML device under high applied voltage and current density, Fig. S17† shows the normalized EL spectra of device U3 at various current densities. Along with the increasing current densities, it shows a slightly blue-shifted emission and the same emission pattern without additional bands. As a result, these diboron-based devices exhibited superior to outstanding performance among reported pure-organic non-doped OLEDs (Table S7†).^{26,27,42,43} Additionally, the approach of the 1 nm-thick EML OLED not only maintains the high-level efficiency but also reveals the potential of low power consumption and fabrication cost reduction. The research on the advancement of ultrathin EML devices will be a significant ongoing study.

Conclusion

In summary, the concept of engineering molecules with high horizontal orientation in neat films was demonstrated in this study. By adding bulky substituents at favorable positions, *t*BuCzDBA not only exhibits a low degree of ACQ effect but also increases the horizontally oriented emitting dipole in pristine films. The excellent nondoped device without any doping layer achieved an EQE of 26.9% by using *t*BuCzDBA as the EML material. Furthermore, ultrathin EML (1 nm) OLEDs exhibited a very low turn-on voltage (2.1 V) and maintained a high efficiency

(22.0%). It is worth noting that device U2 achieved the highest power efficiency of 95.3 lm W⁻¹, indicating the achievement of both energy-saving and low-cost fabrication. We believe that this material design of molecules with a high horizontal ratio and reduced ACQ effect in neat films offers a new perspective for low power/cost consumption OLEDs in the future.

Experimental section

Theoretical calculation

All quantum chemical simulations were performed using the Gaussian 16 program package. The excited states of D-A-D-type molecules are sensitive to functionals,⁴⁴ several functionals including B3LYP, CAMB3LYP, PBE0, BMK, M06-2X, and ω B97XD are selected to evaluate the singlet (S_1) and triplet (T_1) excited energies with the 6-31G* basis set (Table S2†). The calculated S_1 and T_1 energy levels with the BMK functional are in good agreement with the experimental values. All density-functional theory (DFT)/time-dependent (TD) DFT calculations were all carried out on the basis of BMK/6-31G*. TD-DFT was then used to obtain the vertical transitions of the lowest-lying singlet and triplet states and visualized on the Gaussview 6.0 software.

Molecular dynamics

Molecular orientation for amorphous crystalline structures can be expressed as a distribution or in averaged order parameter.⁴⁵ Here, stereographic projections were utilized to demonstrate the distribution of preferred orientations. Each simulation system of the three DBA molecules consists of approximately 100 molecules packed roughly neatly in a cubic unit. All NEMD simulations were performed using LAMMPS⁴⁶ and the Dreiding forcefield.⁴⁷ Periodic boundary conditions were used in all simulations (Fig. S11†). The time step equaled 1 fs for deposition and equilibrium after deposition. The Nose–Hoover method was used to maintain a constant temperature of 600 K for deposition. Then, all MD simulations were used for at least 1000 ps of equilibration to obtain atom position results for calculating orientation at 300 K. All setups for molecular simulations can be found in Table S3.†

Photophysical measurement

UV-vis spectra were taken using a spectrophotometer (U-3300 model, Hitachi), while the steady-state fluorescence (room



temp.) spectra were measured by using a PL spectrophotometer (F-7000, Hitachi). Transient PL and time-dependent emission spectra were obtained using a spectrometer (FLS980, Edinburgh Inst). The HOMO levels of iCzDBA in neat films were determined by using a photoelectron spectrometer (AC-2, Riken Keiki) in air. The horizontal ratio of thin films was determined *via* the variable-angle PL measurements.^{20,48}

Device fabrication

The devices were fabricated by using a thermal evaporator on a clean ITO glass with 30 Ω per square under 10^{-6} torr. The deposition rate for organic materials and aluminum layer was around 0.1–0.2 nm s^{-1} and 0.3–0.4 nm s^{-1} , respectively. And the rate for lithium fluoride was 0.005–0.01 nm s^{-1} . The effective emitting area of the devices was 9.00 mm². Current, voltage, and luminance (I - V - L) were recorded simultaneously using a Keithley 2400 source meter and a CS2000A Konica Minolta spectroradiometer. The hole-only device was made from ITO/MoO₃ (1 nm)/*t*BuCzDBA (1 or 15 nm)/MoO₃ (10 nm)/Al (100 nm), and the electron-only device was composed of ITO/Ca (5 nm)/*t*BuCzDBA (1 or 15 nm)/LiF (1 nm)/Al (100 nm). EQEs and PEs were calibrated using the Lambertian distributions (Fig. S15b[†]). All devices were encapsulated in a glove box and the measurements were performed at room temperature.

Data availability

All supporting data are provided in the ESI[†].

Author contributions

T.-L. W. and C.-H. C. contributed to the manuscript writing and funding acquisition. T.-L. W. mainly contributed to the conceptualization, project administration, visualization, and investigation of material synthesis. J. L. contributed to the writing and investigation of theoretical calculations. C.-M. H., Y.-K. C., and P.-Y. H. contributed to the investigation of device fabrication and measurement. P.-T. L. executed the measurement of spectroscopic ellipsometry. T.-Y. C. contributed to the investigation of emitting dipole orientations. W.-C. L. and W. C. contributed to the investigation and methodology of molecular dynamics simulations. C.-H. Y., L.-Y. H., and H.-W. L. performed the supervision and formal analysis. All authors discussed the progress of research and reviewed the manuscript.

Conflicts of interest

The authors declare no conflict of interest.

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